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74F779

8-Bit Bidirectional Binary Counter with 3-STATE Outputs

General Description

The 74F779 is a fully synchronous 8-stage up/down counter with multiplexed 3-STATE I/O ports for bus-oriented applications. All control functions (hold, count up, count down, synchronous load) are controlled by two mode pins (S $_0$, S $_1$). The device also features carry lookahead for easy cascading. All state changes are initiated by the rising edge of the clock.

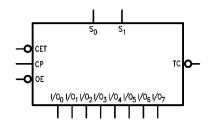
Features

- Multiplexed 3-STATE I/O ports
- Built-in lookahead carry capability
- Count frequency 100 MHz typ
- Supply current 80 mA typ
- Available in SOIC (300 mil only)

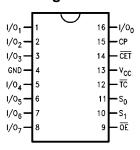
Ordering Code:

Order Number Package Number Package Description				
74F779SC	M16B	16-Lead Small Outline Intergrated Circuit (SOIC), JEDEC MS-013, 0.300" Wide		
74F779PC	N16E	16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide		

Logic Symbol



Connection Diagram



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DS009593

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Unit Loading/Fan Out

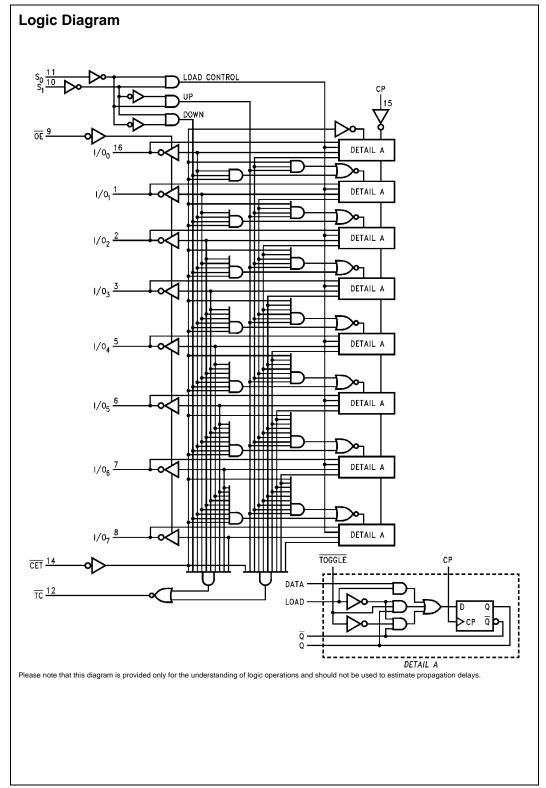
Pin Names	Deceription	U.L.	Input I _{IH} /I _{IL}	
Pin Names	Description	HIGH/LOW	Output I _{OH} /I _{OL}	
I/O ₀ –I/O ₇	Data Inputs	0.25/0.33	5 μA/–0.2 mA	
	Data Outputs	75/15 (12.5)	-3 mA/24 mA (20 mA)	
S ₀ , S ₁ OE	Select Inputs	0.25/0.33	5 μA/–0.2 mA	
OE	Output Enable Input (Active LOW)	0.25/0.33	5 μA/–0.2 mA	
CET	Count Enable Trickle Input (Active LOW)	0.25/0.33	5 μA/–0.2 mA	
CP	Clock Pulse Input (Active Rising Edge)	0.25/0.33	5 μA/–0.2 mA	
TC	Terminal Count Output (Active LOW)	25/12.5	−1 mA/20 mA	

Function Table

S ₁	S ₀	CET	OE	СР	Function
Х	Х	Х	Н	Х	I/O ₀ to I/O ₇ in High Z
Х	Χ	Χ	L	X	Flip-Flop Outputs Appear on I/O Lines
L	L	Χ	Н	~	Parallel Load All Flip-Flops
(No	t LL)	Н	X	~	Hold (TC Held HIGH)
Н	L	L	X	~	Count Up
L	Н	L	X	~	Count Down

H = HIGH Voltage Level
L = LOW Voltage Level
X = Immaterial

= LOW-to-HIGH Clock Transition
(Not LL) means S₀ and S₁ should never both be LOW level at the same time.



Absolute Maximum Ratings(Note 1)

Recommended Operating Conditions

 $\begin{array}{ll} \mbox{Storage Temperature} & -65\mbox{°C to } +150\mbox{°C} \\ \mbox{Ambient Temperature under Bias} & -55\mbox{°C to } +125\mbox{°C} \\ \end{array}$

Junction Temperature under Bias $-35 \,^{\circ}$ C to $+123 \,^{\circ}$ C V_{CC} Pin Potential to Ground Pin -0.5V to +7.0V Input Voltage (Note 2) -0.5V to +7.0V

-30 mA to +5.0 mA

Input Current ((Note 2) $\label{eq:Voltage Applied to Output}$ in HIGH State (with $V_{CC}=0V$)

 $\begin{array}{ll} \text{Standard Output} & -0.5 \text{V to V}_{\text{CC}} \\ \text{3-STATE Output} & -0.5 \text{V to +5.5 V} \end{array}$

Current Applied to Output

Free Air Ambient Temperature 0° C to $+70^{\circ}$ C Supply Voltage +4.5V to +5.5V

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

DC Electrical Characteristics

Symbol	Parameter		Min	Тур	Max	Units	V _{cc}	Conditions	
V _{IH}	Input HIGH Voltage		2.0			V		Recognized as a HIGH Signal	
V _{IL}	Input LOW Voltage				0.8	V		Recognized as a LOW Signal	
V _{CD}	Input Clamp Diode Voltage				-1.2	V	Min	I _{IN} = -18 mA	
V _{OH}	Output HIGH	10% V _{CC}	2.4			V	Min	I _{OH} = -3 mA	
	Voltage	$5\% V_{CC}$	2.7			V	IVIII	10H = -3 IIIA	
V _{OL}	Output LOW	10% V _{CC}			0.5	V	Min	I _{OL} = 20 mA	
	Voltage	$5\% V_{CC}$			0.5	V	IVIII	I _{OL} = 20 mA	
I _{IH}	Input HIGH Current				5.0	μΑ	Max	V _{IN} = 2.7V (Non-I/O Pins)	
I _{BVI}	Input HIGH Current				7.0	μА	Max	V _{IN} = 7.0V (Non-I/O Pins)	
	Breakdown Test				7.0	μΑ	IVIAX	V _{IN} = 7.00 (NOII-1/O PINS)	
I _{BVIT}	Input HIGH Current				0.5	mA	Max	V _{IN} = 5.5V (I/O _n)	
	Breakdown (I/O)				0.5	IIIA	IVIAX	$V_{IN} = 5.5V (I/O_n)$	
I _{CEX}	Output HIGH				50	μА	Max	$V_{OUT} = V_{CC}$	
	Leakage Current				50	μΑ	IVIAX	VOUT = VCC	
V _{ID}	Input Leakage		4.75			V	0.0	I _{ID} = 1.9 μA	
	Test		4.73			V	0.0	All other pins grounded	
I _{OD}	Output Leakage				3.75	μА	0.0	V _{IOD} = 150 mV	
	Circuit Current				3.73	μΛ	0.0	All other pins grounded	
I _{ZZ}	Bus Drainage Test				500	μΑ	0.0	V _{OUT} = 5.25V	
I _{IL}	Input LOW Current				-0.2	mA	Max	V _{IN} = 0.5V (Non I/O Pins)	
I _{IH} + I _{OZH}	Output Leakage Current				70	μΑ	Max	$V_{OUT} = 2.7V (I/O_n)$	
I _{IL} + I _{OZL}	Output Leakage Current				-200	μΑ	Max	$V_{OUT} = 0.5V (I/O_n)$	
los	Output Short-Circuit Current		-60		-150	mA	Max	V _{OUT} = 0V	
I _{CCH}	Power Supply Current				90	mA	Max	V _O = HIGH	
I _{CCL}	Power Supply Current				105	mA	Max	$V_O = LOW$	
I _{CCZ}	Power Supply Current				110	mA	Max	V _O = HIGH Z	

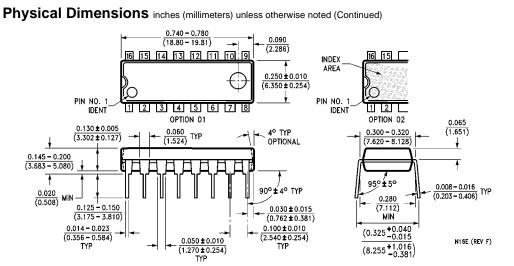
AC Electrical Characteristics

Symbol	Parameter	$T_A = +25^{\circ}C$ $V_{CC} = +5.0V$ $C_L = 50 \text{ pF}$			$T_A = 0$ °C to +70°C $V_{CC} = +5.0V$ $C_L = 50 \text{ pF}$		Units
		Min	Тур	Max	Min	Max	
f _{MAX}	Maximum Clock Frequency	100	105		90		
t _{PLH}	Propagation Delay	3.0	5.0	8.0	3.0	8.5	no
t _{PHL}	CP to I/O _n	5.0	7.5	11.0	5.0	11.0	ns
t _{PLH}	Propagation Delay	5.0	7.5	9.0	5.0	10.0	ns
t _{PHL}	CP to TC	5.0	9.3	10.5	5.0	11.5	115
t _{PLH}	Propagation Delay	2.5	3.8	5.5	2.5	6.0	ns
t _{PHL}	CET to TC	4.5	6.1	8.0	4.5	8.5	IIS
t _{PLH}	Propagation Delay	3.5	6.5	12.0	3.5	13.0	no
t _{PHL}	SN to TC	3.5	7.5	12.0	3.5	13.0	ns
t _{PZH}	Output Enable Time	3.0	5.0	7.0	3.0	8.0	ns
t _{PZL}	OE to I/O _n	5.0	8.0	10.0	5.0	10.5	115
t _{PHZ}	Output Disable Time	1.0	4.0	6.5	1.0	7.0	ns
t _{PLZ}	OE to I/O _n	1.0	3.7	6.5	1.0	7.0	115

AC Operating Requirements

Symbol	Parameter	$T_A = +25$ °C $V_{CC} = +5.0V$		T _A = 0°C to +70°C		Units	
				$V_{CC} = +5.0V$			
		Min	Max	Min	Max	Ī	
t _S (H)	Setup Time	5.0		5.0		ns	
t _S (L)	I/O _n to CP	5.0		5.0		115	
t _H (H)	Hold Time	0.0		0.0		ns	
t _H (L)	I/O _n to CP	0.0		0.0		115	
t _S (H)	Setup Time	9.5		10.0		ns	
t _S (L)	S _n to CP	9.5		10.0		115	
t _H (H)	Hold Time	0.0		0.0		ns	
$t_H(L)$	S _n to CP	0.0		0.0		115	
t _S (H)	Setup Time	7.0		7.0		ns	
t _S (L)	CET to CP	7.0		7.0		115	
t _H (H)	Hold Time	0.0		0.0		ns	
t _H (L)	CET to CP	0.0		0.0		115	
t _W (H)	Clock Pulse Width	4.0		4.0		ns	
$t_W(L)$	HIGH or LOW	4.0		4.0		115	

Physical Dimensions inches (millimeters) unless otherwise noted LEAD NO 1 0.3940-0.4190 10.00-10.65 $\frac{0.0091 - 0.0125}{0.23 - 0.32} \text{ TYP ALL LEADS}$ 0.0160-0.0500 0.40-1.27 TYP ALL LEADS 16-Lead Small Outline Intergrated Circuit (SOIC), JEDEC MS-013, 0.300" Wide Package Number M16B



16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide Package Number N16E

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